

Search Notes 				Application/Control No. 10/721,512 Examiner Hai V. Nguyen	Applicant(s)/Patent under Reexamination KOBAYASHI ET AL.	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
Class	Subclass	Date	Examiner		DATE	EXMR
358	1.14	9/26/2006	HN	EAST search updated	9/26/2006	HN
358	1.15					
INTERFERENCE SEARCHED				 		
Class	Subclass	Date	Examiner			
 				 		